

Search Notes

Application/Control No.

10/784,043

Examiner

Thien M. Le

Applicant(s)/Patent under
Reexamination

CRAIG ET AL.

Art Unit

2876

SEARCHED

Class	Subclass	Date	Examiner
235	462.01- 462.47		
	472.01		
	472.02		
	472.03		
	380		
	375		
	383		
	381		
	385	10/13/2005	LTM

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
235	462.01		
	383	10/13/2005	LTM

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR